Application/Control No. Applicant(s)/Patent Under Reexamination 10/046,926 TEIG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2825 Vuthe Siek U.S. PATENT DOCUMENTS Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 716/12 Α US-6,324,674 11-2001 Andreev et al. US-В US-С US-D US-Ε F US-US-G Н US-1 US-US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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